Application/Control No. Applicant(s)/Patent Under Reexamination 10/624,489 VIERICH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Shew-Fen Lin 2166 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,569,205 B1 05-2003 Poggi, Valerie S. Α 715/500 US-2003/0208460 A1 11-2003 В Srikant et al. 707/1 US-6,801,910 B1 10-2004 Bedell et al. С 707/6 D US-6,807,518 B1 10-2004 Lang, Theodore James 703/2 US-Ε F US-G US-US-US-1 US-J Κ US-US-М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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